UNITED STATES PATENT AND TRADEMARK OFFICE

# CERTIFICATE OF CORRECTION

PATENT NO. : 6,838,122 B2
DATED : January 4, 2005
INVENTOR(S) : Basceri et al.



It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page,

Item [56], **References Cited**, U.S. PATENT DOCUMENTS, insert the following:

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Title page (cont'd),
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Title page (cont'd),
OTHER DOCUMENTS, insert the following:

-- **Aoyama et al., Leakage Current Mechanism of Amorphous and Polycrystalline Ta2O5 Films Grown by Chemical Vapor Deposition, 143 J. ELECTROCHEM SOC., No. 3, pp 977-983 (March 1996).**

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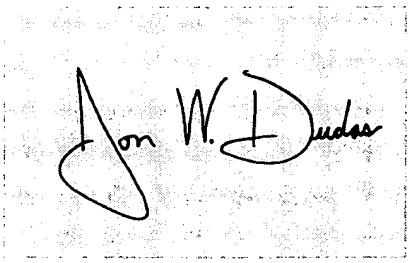
Signed and Sealed this

Eighth Day of November, 2005



JON W. DUDAS
*Director of the United States Patent and Trademark Office*